# DISCRETE SEMICONDUCTORS

# DATA SHEET

# **BLV100**UHF power transistor

**Product specification** 

March 1993





# **UHF** power transistor

# **BLV100**

#### **FEATURES**

- Internal input matching to achieve high power gain
- Ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability.

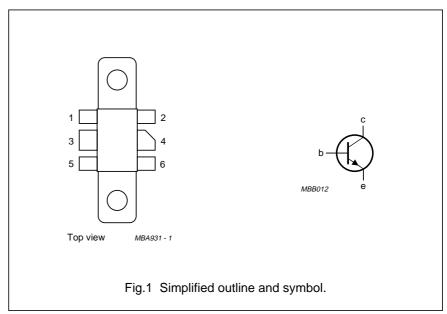
#### **DESCRIPTION**

NPN silicon planar epitaxial transistor in a SOT171 envelope, intended for common emitter, class-AB operation in radio transmitters for the 960 MHz communications band. The transistor has a 6-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

#### **PINNING - SOT171**

| PIN | DESCRIPTION |  |  |  |  |  |
|-----|-------------|--|--|--|--|--|
| 1   | emitter     |  |  |  |  |  |
| 2   | emitter     |  |  |  |  |  |
| 3   | base        |  |  |  |  |  |
| 4   | collector   |  |  |  |  |  |
| 5   | emitter     |  |  |  |  |  |
| 6   | emitter     |  |  |  |  |  |

### **PIN CONFIGURATION**



#### **WARNING**

# Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

# **QUICK REFERENCE DATA**

RF performance up to  $T_h$  = 25 °C in a common emitter class-AB test circuit.

| MODE OF OPERATION | f     | V <sub>CE</sub> | P <sub>L</sub> | G <sub>P</sub> | η <sub>c</sub> |
|-------------------|-------|-----------------|----------------|----------------|----------------|
|                   | (MHz) | (V)             | (W)            | (dB)           | (%)            |
| c.w. class-AB     | 960   | 24              | 8              | > 8            | > 50           |

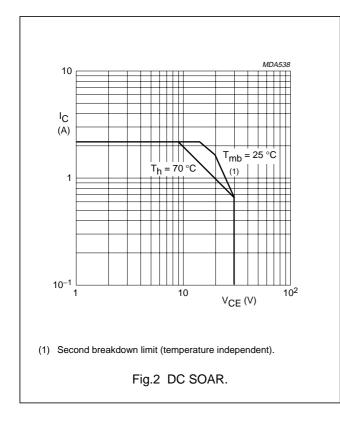
# **UHF** power transistor

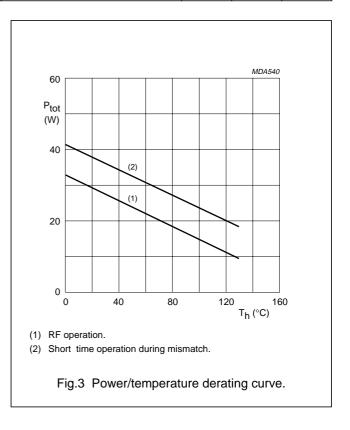
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# **LIMITING VALUES**

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL            | PARAMETER                      | CONDITIONS                            | MIN. | MAX. | UNIT |
|-------------------|--------------------------------|---------------------------------------|------|------|------|
| V <sub>CESM</sub> | collector-emitter voltage      | peak value;<br>V <sub>BE</sub> = 0    | _    | 50   | V    |
| $V_{CEO}$         | collector-emitter voltage      | open base                             | _    | 30   | V    |
| V <sub>EBO</sub>  | emitter-base voltage           | open collector                        | _    | 4    | V    |
| I <sub>C</sub>    | collector current              | DC or average value                   | _    | 2.25 | Α    |
| I <sub>CM</sub>   | collector current              | peak value<br>f > 1 MHz               | _    | 3.5  | А    |
| P <sub>tot</sub>  | total power dissipation        | f > 1 MHz;<br>T <sub>mb</sub> = 25 °C | _    | 31   | W    |
| T <sub>stg</sub>  | storage temperature range      |                                       | -65  | 150  | °C   |
| T <sub>j</sub>    | junction operating temperature |                                       | _    | 200  | °C   |





# THERMAL RESISTANCE

Dissipation = 31 W;  $T_{mb}$  = 25 °C.

| SYMBOL                   | PARAMETER                      | MAX. | UNIT |  |
|--------------------------|--------------------------------|------|------|--|
| R <sub>th j-mb(RF)</sub> | from junction to mounting base | 5.6  | K/W  |  |
| R <sub>th mb-h</sub>     | from mounting base to heatsink | 0.4  | K/W  |  |

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# **CHARACTERISTICS**

 $T_j = 25$  °C.

| SYMBOL               | PARAMETER                           | CONDITIONS  | MIN. | TYP. | MAX. | UNIT |
|----------------------|-------------------------------------|---|------|------|------|------|
| V <sub>(BR)CES</sub> | collector-emitter breakdown voltage | V <sub>BE</sub> = 0;<br>I <sub>C</sub> = 8 mA                   | 50   | _    | _    | V    |
| V <sub>(BR)CEO</sub> | collector-emitter breakdown voltage | open base;<br>I <sub>C</sub> = 60 mA                            | 30   | _    | _    | V    |
| V <sub>(BR)EBO</sub> | emitter-base breakdown voltage      | open collector;<br>I <sub>E</sub> = 4 mA                        | 4    | _    | _    | V    |
| I <sub>CES</sub>     | collector-emitter leakage current   | V <sub>BE</sub> = 0;<br>V <sub>CE</sub> = 30 V                  | _    | _    | 2    | mA   |
| h <sub>FE</sub>      | DC current gain                     | V <sub>CE</sub> = 25 V;<br>I <sub>C</sub> = 0.6 A               | 20   | 75   | _    | ٤    |
| C <sub>c</sub>       | collector capacitance               | $V_{CB} = 25 \text{ V};$ $I_E = I_e = 0;$ $f = 1 \text{ MHz}$   | _    | 13.5 | _    | pF   |
| C <sub>re</sub>      | feedback capacitance                | V <sub>CE</sub> = 25 V;<br>I <sub>C</sub> = 40 mA;<br>f = 1 MHz | _    | 8.4  | _    | pF   |
| C <sub>c-f</sub>     | collector-flange capacitance        |   | _    | 2    | _    | pF   |

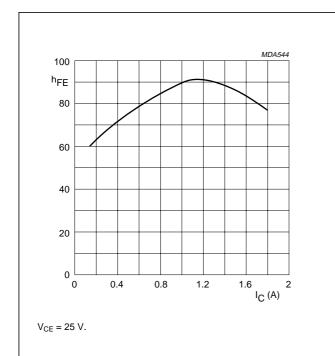


Fig.4 DC current gain as a function of collector current, typical values.

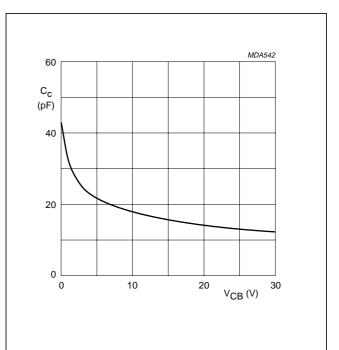


Fig.5 Output capacitance as a function of collector-base voltage, typical values.

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#### **APPLICATION INFORMATION**

RF performance in a class-AB circuit;  $T_h$  = 25 °C;  $R_{th\ mb-h}$  = 0.4 K/W, unless otherwise specified.

| MODE OF OPERATION | f<br>(MHz) | V <sub>CE</sub> (V) | I <sub>CQ</sub><br>(mA) | P <sub>L</sub><br>(W) | G <sub>P</sub><br>(dB) | η <sub>c</sub><br>(%) |
|-------------------|------------|---------------------|-------------------------|-----------------------|------------------------|-----------------------|
| c.w. class-AB     | 960        | 24                  | 20                      | 8                     | > 8                    | > 50                  |
|                   |            |                     |                         |                       | typ. 9                 | typ. 55               |

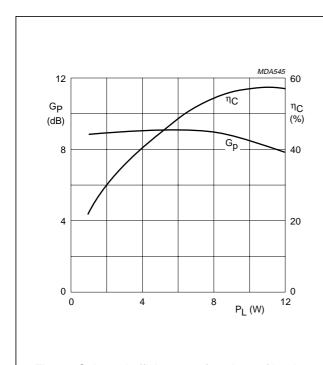


Fig.6 Gain and efficiency as functions of load power, typical values.

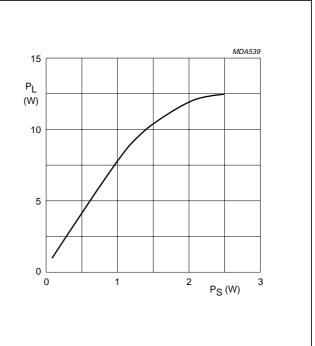


Fig.7 Load power as a function of drive power, typical values.

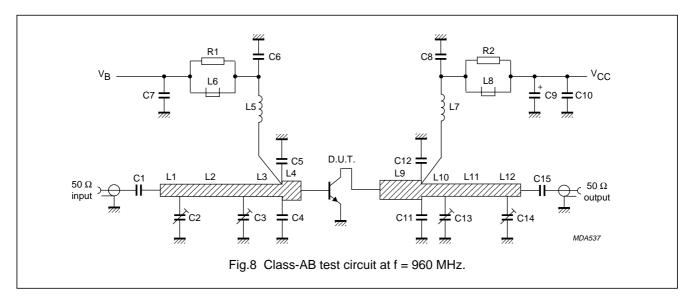
# Ruggedness in class-AB operation

The BLV100 is capable of withstanding a load mismatch corresponding to VSWR = 10:1 through all phases, under the following conditions:

 $V_{CE}$  = 24 V, f = 960 MHz, and rated output power.

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# List of components (see test circuit)

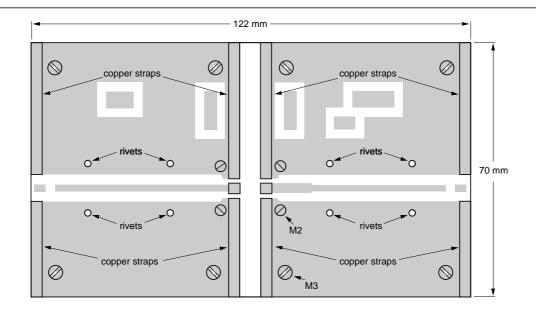
| COMPONENT              | DESCRIPTION                                | VALUE                     | DIMENSIONS  | CATALOGUE<br>NO. |
|------------------------|--|---------------------------|---|------------------|
| C1, C6, C7,<br>C8, C15 | multilayer ceramic chip capacitor          | 330 pF                    |   |                  |
| C2, C3, C13,<br>C14    | film dielectric trimmer                    | 1.4 to 5.5 pF             |   | 2222 809 09001   |
| C4, C5                 | multilayer ceramic chip capacitor (note 1) | 5.1 pF                    |   |                  |
| C9                     | 35 V solid aluminium capacitor             | 2.2 μF                    |   | 2222 128 50228   |
| C10                    | multilayer ceramic chip capacitor          | 3 × 100 pF<br>in parallel |   |                  |
| C11, C12               | multilayer ceramic chip capacitor (note 2) | 6.2 pF                    |   |                  |
| L1, L12                | microstrip (note 3)                        | 50 Ω                      | 9 × 2.4 mm  |                  |
| L2, L11                | microstrip (note 3)                        | 50 Ω                      | 23 × 2.4 mm                                       |                  |
| L3                     | microstrip (note 3)                        | 50 Ω                      | 16 × 2.4 mm                                       |                  |
| L4                     | microstrip (note 3)                        | 43 Ω                      | 3 × 3 mm  |                  |
| L5                     | 3 turns enamelled 0.8 mm copper wire       |                           | int. dia. 3 mm;<br>length 5 mm;<br>leads 2 × 5 mm |                  |
| L6, L8                 | grade 3B Ferroxcube wideband RF choke      |                           |   | 4312 020 36642   |
| L7                     | 4 turns enamelled 0.8 mm copper wire       |                           | int. dia. 4 mm;<br>length 5 mm;<br>leads 2 × 5 mm |                  |
| L9                     | microstrip (note 3)                        | 43 Ω                      | 14.5 mm × 3 mm;                                   |                  |
| L10                    | microstrip (note 3)                        | 50 Ω                      | 4.5 mm × 2.4 mm;                                  |                  |
| R1, R2                 | 0.4 W metal film resistor                  | 10 Ω                      |   | 2322 151 71009   |

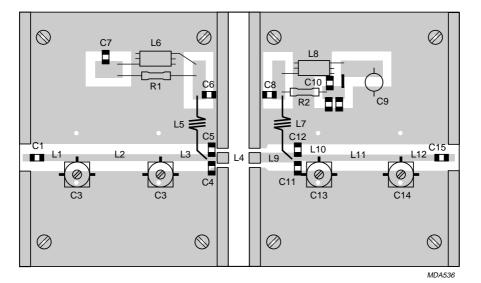
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#### **Notes**

- 1. American Technical Ceramics capacitor type 100A, or capacitor of the same quality.
- 2. American Technical Ceramics capacitor type 100B, or capacitor of the same quality.
- 3. The microstrips are on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric ( $\varepsilon_r = 2.2$ ), thickness  $\frac{1}{32}$  inch.





The circuit and components are situated on one side of the PTFE fibre-glass board, the other side being fully metallized to serve as an earth. Earth connections are made by means of fixing screws, hollow rivets and straps around the board and under the emitters, to provide a direct contact between the component ground plane.

Fig.9 Component layout for 960 MHz test circuit.

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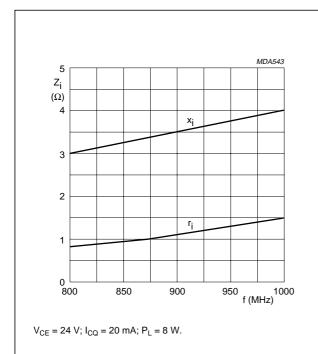


Fig.10 Input impedance (series components) as a function of frequency, typical values.

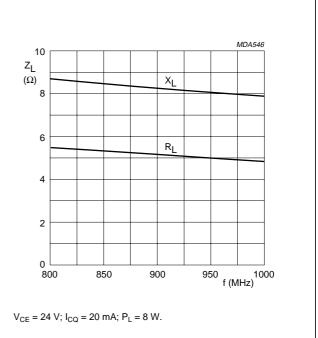
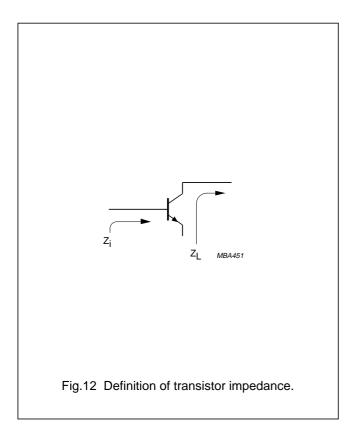
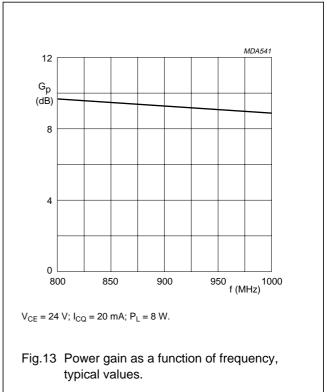


Fig.11 Load impedance (series components) as a function of frequency, typical values.





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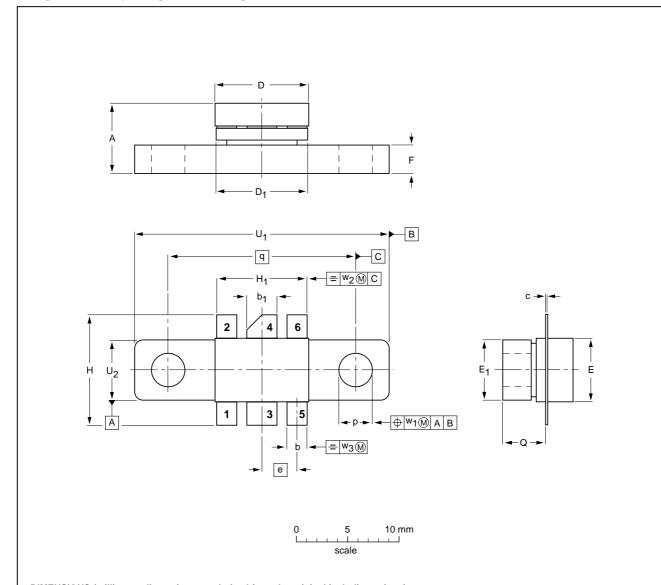
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# **PACKAGE OUTLINE**

Flanged ceramic package; 2 mounting holes; 6 leads

SOT171A



# DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

| UNIT | Α              | b            | b <sub>1</sub> | C            | D            | D <sub>1</sub> | Е            | E <sub>1</sub> | е     | F              | Н              | Н <sub>1</sub> | р              | Q              | q     | U <sub>1</sub> | U <sub>2</sub> | w <sub>1</sub> | w <sub>2</sub> | w <sub>3</sub> |
|------|----------------|--------------|----------------|--------------|--------------|----------------|--------------|----------------|-------|----------------|----------------|----------------|----------------|----------------|-------|----------------|----------------|----------------|----------------|----------------|
| mm   | 6.81<br>6.07   | 2.15<br>1.85 | 3.20<br>2.89   | 0.16<br>0.07 | 9.25<br>9.04 | 9.30<br>8.99   | 5.95<br>5.74 | 6.00<br>5.70   | 3.58  | 3.05<br>2.54   | 11.31<br>10.54 |                | 3.43<br>3.17   | 4.32<br>4.11   | 18.42 | 24.90<br>24.63 |                | 0.51           | 1.02           | 0.26           |
|      | 0.268<br>0.239 |              |                |              |              |                |              | 0.236<br>0.224 | 0.140 | 0.120<br>0.100 | 0.445<br>0.415 | 0.365<br>0.355 | 0.135<br>0.125 | 0.170<br>0.162 | 0.725 | 0.980<br>0.970 | 0.236<br>0.224 | 0.02           | 0.04           | 0.01           |

| OUTLINE |     | REFER | EUROPEAN | ISSUE DATE |            |            |
|---------|-----|-------|----------|------------|------------|------------|
| VERSION | IEC | JEDEC | EIAJ     |            | PROJECTION | ISSUE DATE |
| SOT171A |     |       |          |            |            | 97-06-28   |

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### **DEFINITIONS**

| Data Sheet Status         |   |
|---------------------------|---|
| Objective specification   | This data sheet contains target or goal specifications for product development.       |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification     | This data sheet contains final product specifications.                                |
| Limiting values           |   |

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

### **Application information**

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.